

P-Channel -20V (D-S) MOSFET

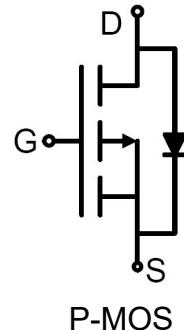
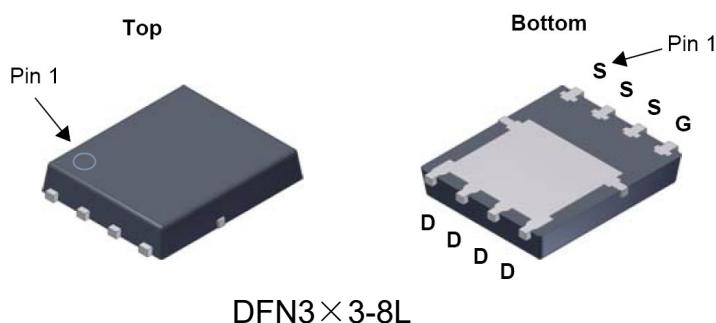
● FEATURES

RDS(ON) $\leq 9\text{m}\Omega$ @ VGS = -4.5V
 RDS(ON) $\leq 12\text{m}\Omega$ @ VGS = -2.5V
 RDS(ON) $\leq 18\text{m}\Omega$ @ VGS = -1.8V
 high density cell design for extremely low RDS(ON)

● GENERAL DESCRIPTION

The FS4477B combines advanced trench MOSFET technology with a low resistance package to provide extremely low R_{DS(ON)}. This device is ideal for load switch and battery protection applications.

● PIN CONFIGURATION



● Absolute Maximum Ratings (TA=25°C Unless Otherwise Noted)

Absolute Maximum Ratings TA=25°C unless otherwise noted				
Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	-20	V
Gate-Source Voltage		V _{GS}	± 8	V
Continuous Drain Current G	TC=25°C	ID	-40	A
Current G			-29	
Pulsed Drain Current C		IDM	-100	
Continuous Drain Current	TA=25°C	IDSM	-14.5	A
Current			-11.5	
Avalanche Current C		I _{AS} , I _{AR}	-40	A
Avalanche energy L=0.1mH C		E _{AS} , E _{AR}	80	mJ
Power Dissipation B	TC=25°C	PD	29	W
			12	
Power Dissipation A	TA=25°C	PDSM	3.1	W
			2	
Junction and Storage Temperature Range		T _J , T _{TSG}	-55 to 150	°C

* The device mounted on 1in² FR4 board with 2 oz copper

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- Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-20	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=-20\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 8\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-0.3	-0.55	-0.9	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-14\text{A}$ $V_{\text{GS}}=-2.5\text{V}, I_{\text{D}}=-13\text{A}$ $V_{\text{GS}}=-1.8\text{V}, I_{\text{D}}=-11\text{A}$	-	7.6 9.3 11.4	9 12 18	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-15\text{A}$	-	20	-	S
Dynamic Characteristics (Note 4)						
Input Capacitance	C_{iss}	$V_{\text{DS}}=-15\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	3250	-	PF
Output Capacitance	C_{oss}		-	605	-	PF
Reverse Transfer Capacitance	C_{rss}		-	565	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=-15\text{V}, I_{\text{D}}=-10\text{A}$ $V_{\text{GS}}=-8\text{V}, R_{\text{GEN}}=6\Omega$	-	13	-	nS
Turn-on Rise Time	t_{r}		-	12	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	50	-	nS
Turn-Off Fall Time	t_{f}		-	14	-	nS
Total Gate Charge	Q_{g}		-	84	-	nC
Gate-Source Charge	Q_{gs}		-	11.7	-	nC
Gate-Drain Charge	Q_{gd}		-	25	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{s}}=-10\text{A}$	-	-0.85	-1.2	V
Diode Forward Current	I_{s}		-	-	-50	A
Reverse Recovery Time	t_{rr}	$T_J = 25^\circ\text{C}, IF = -10\text{A}$ $di/dt = 100\text{A}/\mu\text{s}$ (Note 3)	-	-	45	nS
Reverse Recovery Charge	Q_{rr}		-	-	43	nC
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

- A. The value of R_{qJA} is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with $TA = 25^\circ\text{C}$. The Power dissipation PD_{SM} is based on R_{qJA} $t \leq 10\text{s}$ value and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.
- B. The power dissipation PD is based on $T_J(\text{MAX})=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Repetitive rating, pulse width limited by junction temperature $T_J(\text{MAX})=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $TJ=25^\circ\text{C}$.
- D. The R_{qJA} is the sum of the thermal impedance from junction to case R_{qJC} and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using $<300\text{ms}$ pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_J(\text{MAX})=150^\circ\text{C}$. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in2 FR-4 board with 2oz. Copper, in a still air environment with $TA=25^\circ\text{C}$.

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- TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

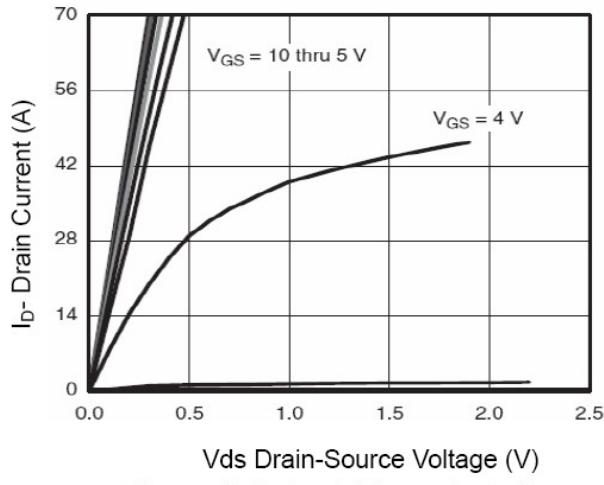


Figure 1 Output Characteristics

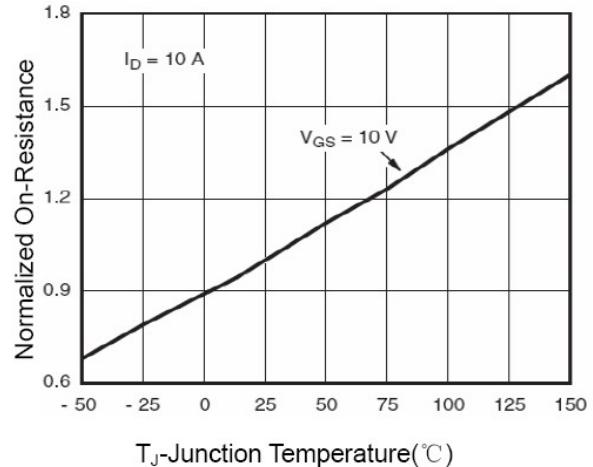


Figure 4 Rdson-Junction Temperature

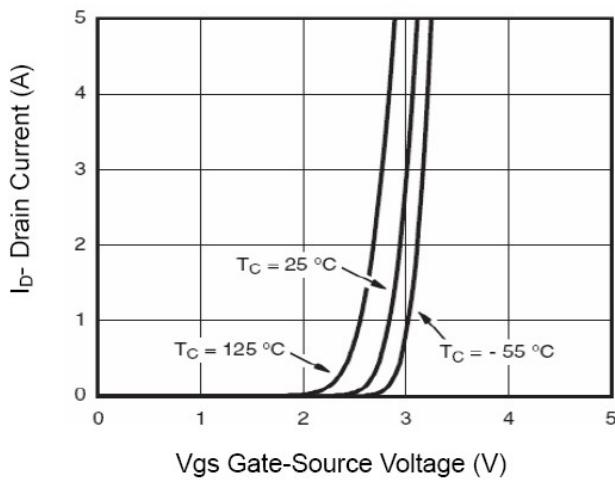


Figure 2 Transfer Characteristics

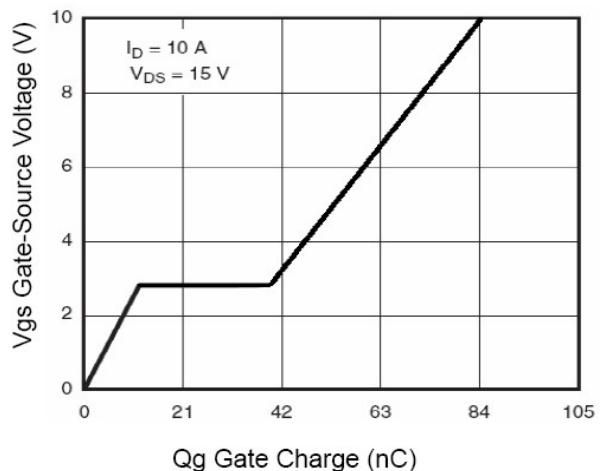


Figure 5 Gate Charge

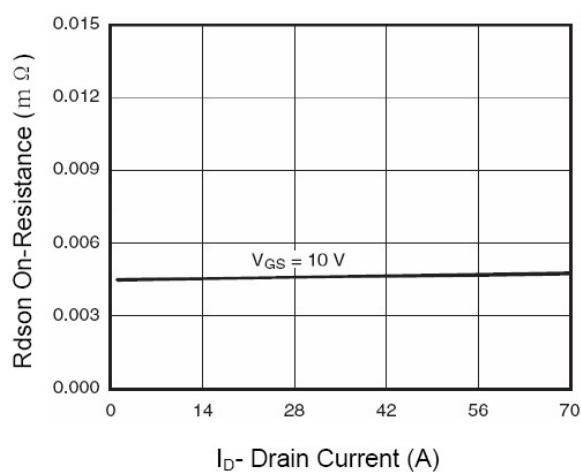


Figure 3 Rdson- Drain Current

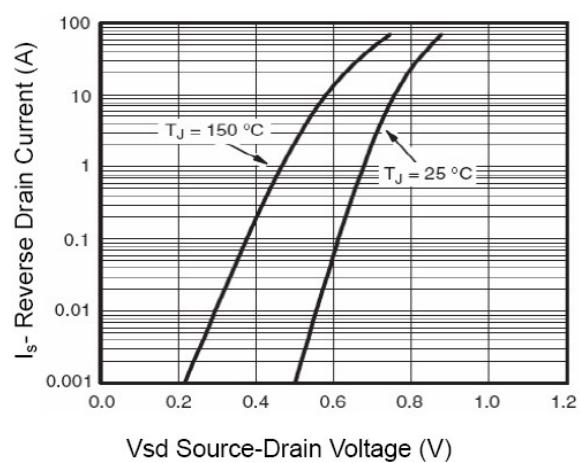
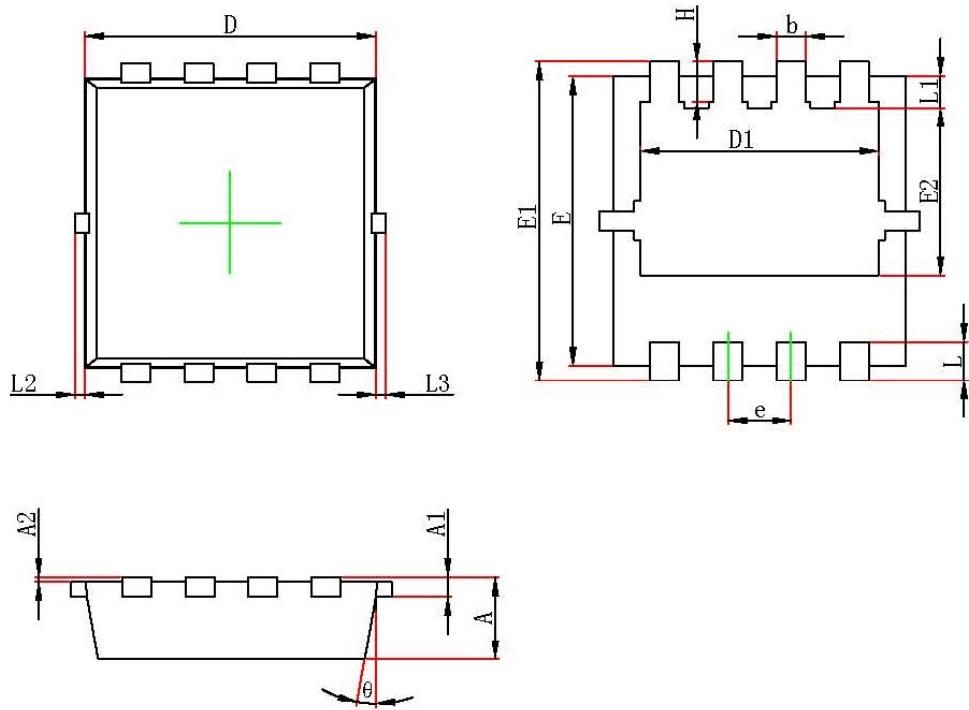


Figure 6 Source- Drain Diode Forward

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- PACKAGE DFN3×3-8L



DFN3030-8L: mm			
Dim	Min	Max	Typ
A	0.65	0.85	0.75
A1	0.152Ref.		
A2	0	0.05	0.03
D	2.90	3.10	3.00
D1	2.24	2.54	2.39
E	2.90	3.10	3.00
E1	3.15	3.45	3.30
E2	1.23	1.64	1.43
e	0.55	0.75	0.65
b	0.20	0.40	0.30
L	0.30	0.50	0.40
L1	0.18	0.48	0.33
L2	0	0.10	0.05
L3	0	0.10	0.05
H	0.31	0.52	0.42
θ	9°	13°	11°